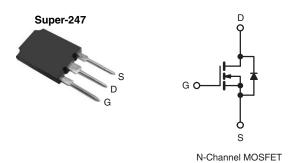
Vishay Siliconix

D Series Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	550				
$R_{DS(on)}$ max. at 25 °C (Ω) $V_{GS} = 10 \text{ V}$ 0.130					
Q _g max. (nC)	125				
Q _{gs} (nC)	23				
Q _{gd} (nC)	37				
Configuration	Single				



FEATURES

- Optimal Design
 - Low Area specific On-Resistance
 - Low Input Capacitance (Ciss)
 - Reduced Capacitive Switching Losses
 - High Body Diode Ruggedness
 - Avalanche Energy Rated (UIS)
- · Optimal Efficiency and Operation
 - Low Cost
 - Simple Gate Drive Circuitry
 - Low Figure-Of-Merit (FOM): Ron x Qa
 - Fast Switching
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912

APPLICATIONS

- Consumer Electronics
 - Displays (LCD or Plasma TV
- Server and Telecom Power Supplies
 - SMPS
- Industrial
 - Welding, Induction Heating, Motor Drives
- · Battery Chargers

ORDERING INFORMATION			
Package	Super-247		
Lead (Pb)-free	SiHS36N50D-E3		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500		
Gate-Source Voltage			V	± 30	V	
Gate-Source Voltage AC (f > 1 Hz)			V_{GS}	30		
Continuous Drain Current (T = 150 °C)	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	- I _D	36	А	
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 100 °C		23		
Pulsed Drain Current ^a			I _{DM}	112		
Linear Derating Factor				3.6	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	332	mJ	
Maximum Power Dissipation			P_{D}	446	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		dV/dt	24	V/ns	
Reverse Diode dV/dt ^d			uv/ul	0.1	7 V/ris	
Soldering Recommendations (Peak Temperature) for 10 s				300°	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD}=50$ V, starting $T_J=25$ °C, L=2.3 mH, $R_g=25$ Ω , $I_{AS}=17$ A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, starting $T_J = 25$ °C.



Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.28	C/VV		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•		
Drain-Source Breakdown Voltage	V_{DS}	V _{GS} :	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 250 μA	-	0.52	-	V/°C
Gate Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	3.0	-	5.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 100	nA
	_	V _{DS} = 500 V, V _{GS} = 0 V		-	-	1	_
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 18 A	-	0.105	0.130	Ω
Forward Transconductancea	9 _{fs}	V _{DS}	= 50 V, I _D = 18 A	-	12.8	-	S
Dynamic						I	
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	3233	-	
Output Capacitance	C _{oss}	1	$V_{DS} = 100 \text{ V},$	-	285	-	-
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		-	25	-	1
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V _{GS} = 0 V, V _{DS} = 0 V to 400 V		-	240	-	pF
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	352	-	
Total Gate Charge	Qg			-	83	125	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	V _{GS} = 10 V		23	-	nC
Gate-Drain Charge	Q _{gd}			-	37	-	
Turn-On Delay Time	t _{d(on)}			-	33	66	
Rise Time	t _r	$V_{DD} = 400 \text{ V}, I_{D} = 18 \text{ A}, $ $V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		ı	89	134	ns
Turn-Off Delay Time	$t_{d(off)}$			ı	79	119	
Fall Time	t _f			-	68	102	
Gate Input Resistance	R_g	f = 1 MHz, open drain		-	1.8	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	36	
Pulsed Diode Forward Current	I _{SM}			-	-	144	_ A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 18 A, V _{GS} = 0 V		-	-	1.2	V
Reverse Recovery Time	t _{rr}	0 7 0 1 7 do 1		-	490	-	ns
Reverse Recovery Charge	Q _{rr}	$T_{J} = 2$	5 °C, I _F = I _S = 18 A,	_	8.2	-	μC
Reverse Recovery Current	I _{RRM}	dl/dt = 100 A/µs, V _R = 20 V		_	31	_	Α

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

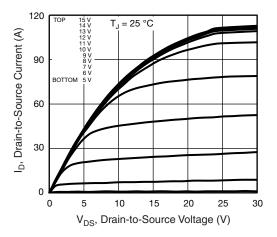


Fig. 1 - Typical Output Characteristics

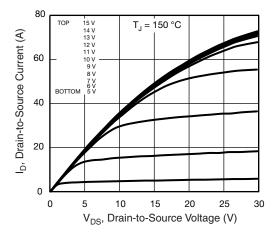


Fig. 2 - Typical Output Characteristics

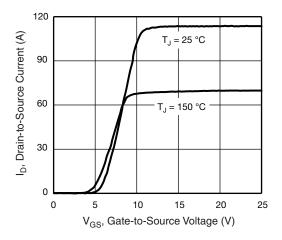


Fig. 3 - Typical Transfer Characteristics

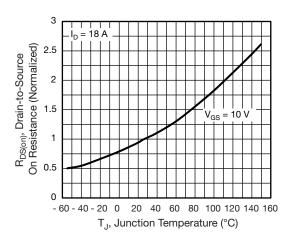


Fig. 4 - Normalized On-Resistance vs. Temperature

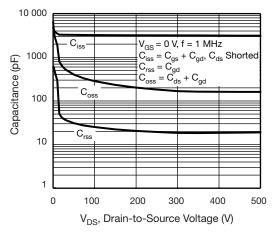


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

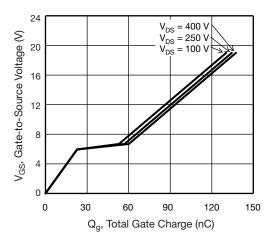


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



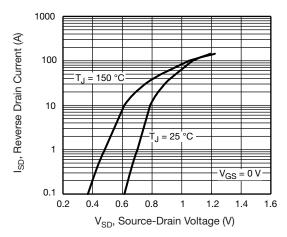


Fig. 7 - Typical Source-Drain Diode Forward Voltage

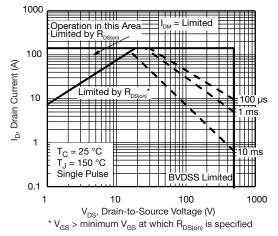


Fig. 8 - Maximum Safe Operating Area

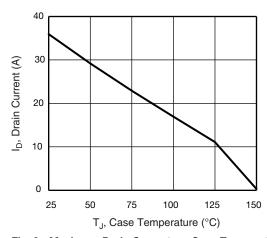


Fig. 9 - Maximum Drain Current vs. Case Temperature

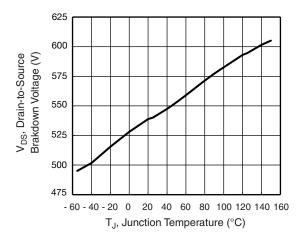


Fig. 10 - Temperature vs. Drain-to-Source Voltage

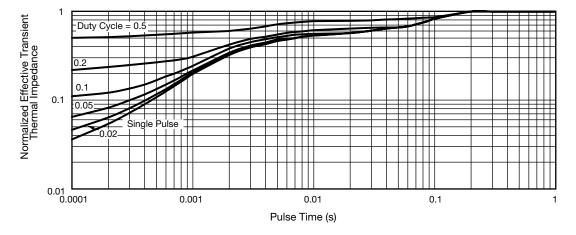


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



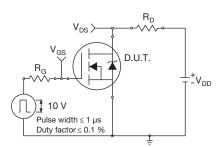


Fig. 12 - Switching Time Test Circuit

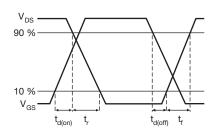


Fig. 13 - Switching Time Waveforms

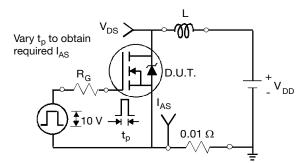


Fig. 14 - Unclamped Inductive Test Circuit

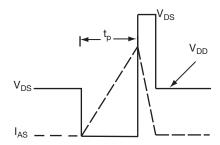


Fig. 15 - Unclamped Inductive Waveforms

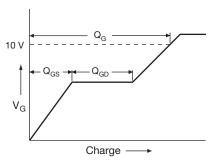


Fig. 16 - Basic Gate Charge Waveform

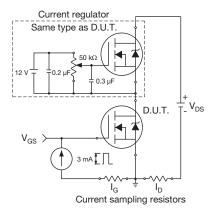
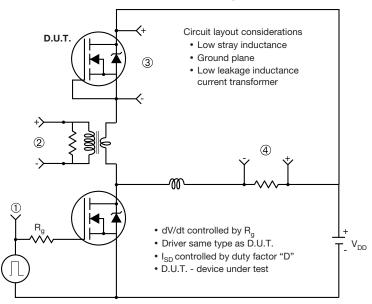


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



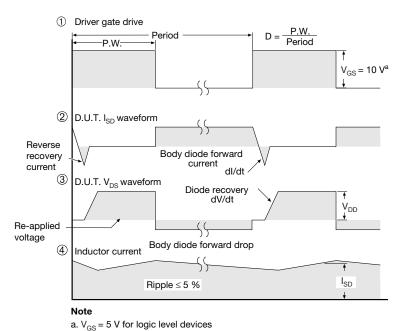
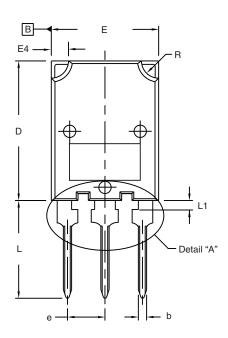


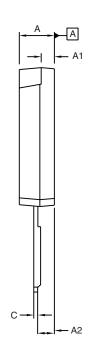
Fig. 18 - For N-Channel

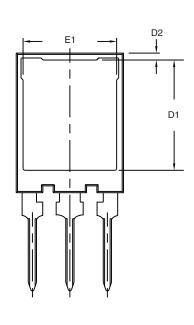
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91514.

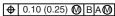


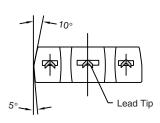
TO-274AA (High Voltage)

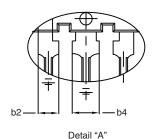












Scale: 2:1

	MILLIM	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.30	0.185	0.209
A1	1.50	2.50	0.059	0.098
A2	2.25	2.65	0.089	0.104
b	1.30	1.60	0.051	0.063
b2	1.80	2.20	0.071	0.087
b4	3.00	3.25	0.118	0.128
c ⁽¹⁾	0.38	0.89	0.015	0.035
D	19.80	20.80	0.780	0.819

	MILLIM	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	15.50	16.10	0.610	0.634
D2	0.70	1.30	0.028	0.051
Е	15.10	16.10	0.594	0.634
E1	13.30	13.90	0.524	0.547
е	5.45 BSC		0.215 BSC	
L	13.70	14.70	0.539	0.579
L1	1.00	1.60	0.039	0.063
R	2.00	3.00	0.079	0.118

ECN: X17-0056-Rev. B, 27-Mar-17

DWG: 5975

Notes

- Dimensioning and tolerancing per ASME Y14.5M-1994
- Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outer extremes of the plastic body
- Outline conforms to JEDEC® outline to TO-274AA
- (1) Dimension measured at tip of lead



Legal Disclaimer Notice

Vishay

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